

FC140

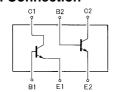
NPN Epitaxial Planar Silicon Composite Transistor

High-Speed Switching Applications

Features

- · Composite type with 2 transistors contained in the CP package currently in use, improving the mounting efficiency greatly.
- · Small output capacitance, high gain-bandwidth product.
- The FC140 is formed with two chips, being equivalent to the 2SC4452, placed in one package.

Electrical Connection



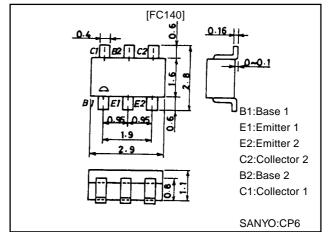
Specifications

Absolute Maximum Ratings at Ta = 25°C

Package Dimensions

unit:mm

2074



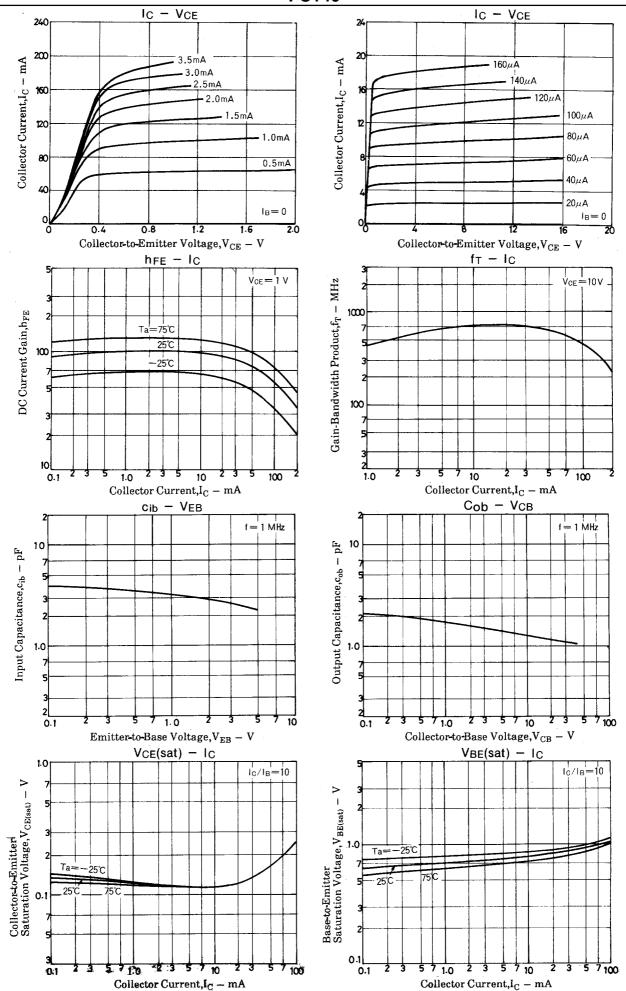
Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	V _{CBO}		40	V
Collector-to-Emitter Voltage	VCES		40	V
Collector-to-Emitter Voltage	VCEO		15	V
Emitter-to-Base Voltage	V _{EBO}		5	V
Collector Current	lС		200	mA
Collector Current (Pulse)	I _{CP}		500	mA
Base Current	Ι _Β		40	mA
Collector Dissipation	PC	1 unit	200	mW
Total Power Dissipation	PT		300	mW
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

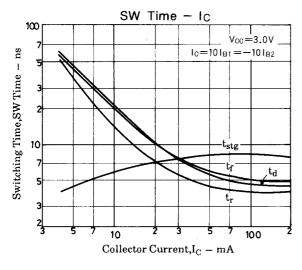
Electrical Characteristics at Ta = 25°C

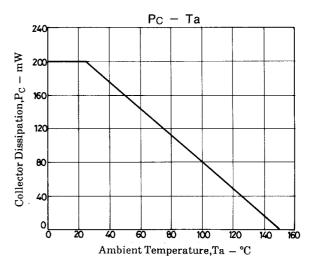
Parameter	Symbol	Conditons	Ratings			Unit
			min	typ	max	Offic
Collector Cutoff Current	ICBO	V _{CB} =20V, I _E =0			0.1	μΑ
Emitter Cutoff Current	I _{EBO}	V _{EB} =3V, I _C =0			0.1	μΑ
DC Current Gain	hFE	V _{CE} =1V, I _C =10mA	90		240	
DC Current Gain Ratio	h _{FE(small/large)}	VCE=1V, IC=10mA	0.6	0.98		
Gain-Bandwidth Product	fT	V _{CE} =10V, I _C =10mA	450	750		MHz
Output Capacitance	Cob	V _{CB} =5V, f=1MHz		1.4	4.0	pF
C-E Saturation Voltage	V _{CE(sat)}	I _C =10mA, I _B =1mA		0.13	0.25	V
B-E Saturation Voltage	V _{BE(sat)}	I _C =10mA, I _B =1mA		0.80	0.85	V
C-B Breakdown Voltage	V(BR)CBO	I _C =10μA, I _E =0	40			V
C-E Breakdown Voltage	V(BR)CEO	I _C =1mA, R _{BE} =∞	15			V
E-B Breakdown Voltage	V _{(BR)EBO}	I _E =10μA, I _C =0	5			V
Turn-ON Time	ton	See specified Test Circuit.		8.0		ns
Storage Time	t _{stg}	See specified Test Circuit.		6.0		ns
Turn-OFF Time	t _{off}	See specified Test Circuit.		12		ns

Note: The specifications shown above are for each individual transistor.

Marking:140

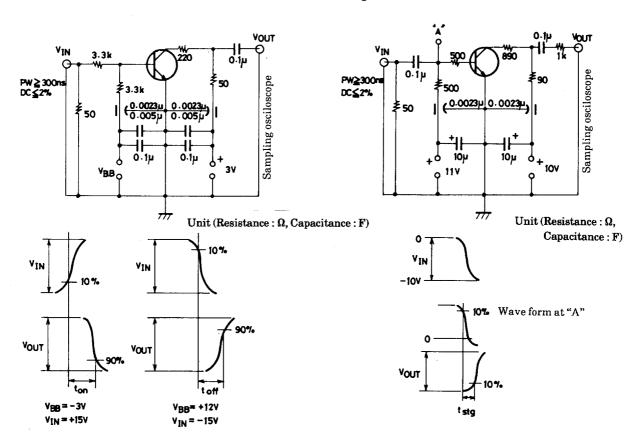






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^tstg Test Cirsuit



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